Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/613,651	HATANO ET AL.
Examiner	Art Unit
Christopher P. Schwartz	3683

	SEARCHED				
Class	Subclass	Date	Examiner		
,					
<b></b> .					
•					

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
267	all above	7/27/2005	CPS
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
earch Updated	7/27/2005	CPS	
	·		